

<b>Notice of References Cited</b>	Application/Control No. 10/553,842	Applicant(s)/Patent Under Reexamination MIYAKE ET AL.	
	Examiner <i>Quyen P. Leung</i> Quyen P. Leung	Art Unit 2874	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0159734	10-2002	Sasaoka et al.	385/125
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	JP 08220378 A	08-1996	Japan	SHIRAISHI et al.	
	P	JP 2002323625 A	11-2002	Japan	SASAKA et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	RAW MACHINE ENGLISH TRANSLATION OF JP 05288967 A, PRINTED ON 5/8/2007
	V	RAW MACHINE ENGLISH TRANSLATION OF JP 08220378 A, PRINTED ON 5/8/2007
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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